

## Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.056		V/°C	Reference to 25 $^{\circ}$ C, $I_{D}$ = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		30	37	mil	V <sub>GS</sub> = 10V, I <sub>D</sub> = 15A ④
			35	43		V <sub>GS</sub> = 5.0V, I <sub>D</sub> = 13A ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0		3.0	٧	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	15			S	$V_{DS} = 25V, I_{D} = 15A \oplus$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 55V, V_{GS} = 0V$
				250		$V_{DS} = 44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage			200	7 IIA	V <sub>GS</sub> = 16V
				-200		V <sub>GS</sub> = -16V

## Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Total Gate Charge			20		I <sub>D</sub> = 15A
Gate-to-Source Charge			5.6	nC	$V_{DS} = 44V$
Gate-to-Drain Charge			9.0		V <sub>GS</sub> = 5.0V, See Fig.6 & 13 ④
Turn-On Delay Time		8.0			$V_{DD} = 28V$
Rise Time		57		nc	I <sub>D</sub> = 15A
Turn-Off Delay Time		25		115	$R_G = 24\Omega$
Fall Time		37			$R_D = 5.0\Omega$ , See Fig. 18 @
Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
Internal Source Inductance		7.5			from package and center of die contact:
Input Capacitance		710			$V_{GS} = 0V$
Output Capacitance		150			$V_{DS} = 25V$
Reverse Transfer Capacitance		28		nE	f = 1.0MHz, See Fig. 5
Output Capacitance		890		PΓ	$V_{GS} = 0V$ , $V_{DS} = 1.0V$ $f = 1.0MHz$
Output Capacitance		110			$V_{GS} = 0V$ , $V_{DS} = 44V$ $f = 1.0MHz$
Effective Output Capacitance		210			$V_{GS}$ = 0V, $V_{DS}$ = 0V to 44V
	Gate-to-Source Charge Gate-to-Drain Charge Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Internal Drain Inductance Internal Source Inductance Input Capacitance Output Capacitance Reverse Transfer Capacitance Output Capacitance Output Capacitance Output Capacitance Output Capacitance	Gate-to-Source Charge —— Gate-to-Drain Charge —— Turn-On Delay Time —— Rise Time —— Turn-Off Delay Time —— Fall Time —— Internal Drain Inductance —— Input Capacitance —— Output Capacitance —— Reverse Transfer Capacitance —— Output Capacitance ——	Gate-to-Source Charge         —         —           Gate-to-Drain Charge         —         —           Turn-On Delay Time         —         57           Rise Time         —         25           Fall Time         —         37           Internal Drain Inductance         —         4.5           Internal Source Inductance         —         7.5           Input Capacitance         —         710           Output Capacitance         —         28           Output Capacitance         —         890           Output Capacitance         —         110	Gate-to-Source Charge         —         5.6           Gate-to-Drain Charge         —         9.0           Turn-On Delay Time         —         8.0         —           Rise Time         —         57         —           Turn-Off Delay Time         —         25         —           Fall Time         —         37         —           Internal Drain Inductance         —         4.5         —           Input Capacitance Inductance         —         7.5         —           Input Capacitance         —         710         —           Reverse Transfer Capacitance         —         28         —           Output Capacitance         —         890         —           Output Capacitance         —         110         —	Gate-to-Source Charge         —         —         5.6         nC           Gate-to-Drain Charge         —         —         9.0           Turn-On Delay Time         —         8.0         —           Rise Time         —         57         —           Turn-Off Delay Time         —         25         —           Fall Time         —         37         —           Internal Drain Inductance         —         4.5         —           Input Capacitance Inductance         —         7.5         —           Input Capacitance         —         710         —           Output Capacitance         —         28         —           Output Capacitance         —         890         —           Output Capacitance         —         110         —

### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			25		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			100		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 15A, V_{GS} = 0V $ ④
t <sub>rr</sub>	Reverse Recovery Time		52	78	ns	$T_J = 25^{\circ}C$ , $I_F = 15A$ , $V_{DD} = 28V$
$Q_{rr}$	Reverse Recovery Charge		82	120	nC	di/dt = 100A/μs ④
t <sub>on</sub>	Forward Turn-On Time	Intrinsi	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )			

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 0.55mH,  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = 15A,  $V_{GS}$  =10V.
- $\label{eq:local_local_local_local} \ensuremath{\Im} \quad I_{SD} \leq 25A, \ di/dt \leq 290A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .
- $\odot$  C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>
- © Limited by T<sub>Jmax</sub>, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- This value determined from sample failure population, starting 100% tested to this value in production.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- $\mathfrak{P}_{\theta}$  is measured at T<sub>J</sub> approximately 90°C.



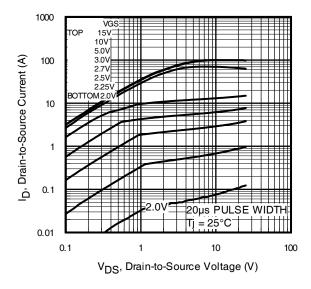


Fig. 1 Typical Output Characteristics

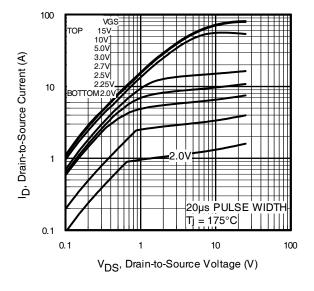


Fig. 2 Typical Output Characteristics

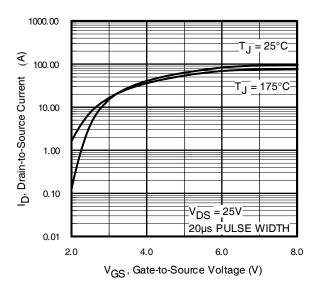
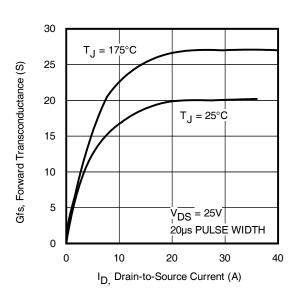
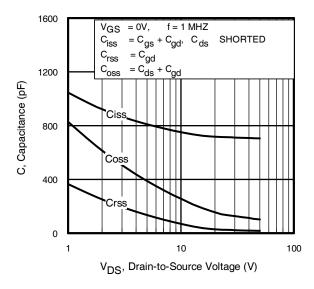


Fig. 3 Typical Transfer Characteristics

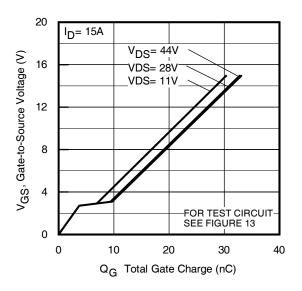


**Fig. 4** Typical Forward Trans conductance Vs. Drain Current





**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage

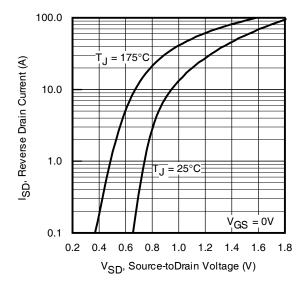


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

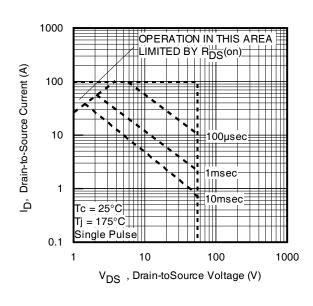
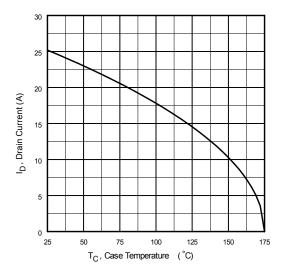
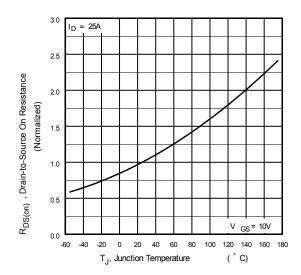


Fig 8. Maximum Safe Operating Area







**Fig 9.** Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

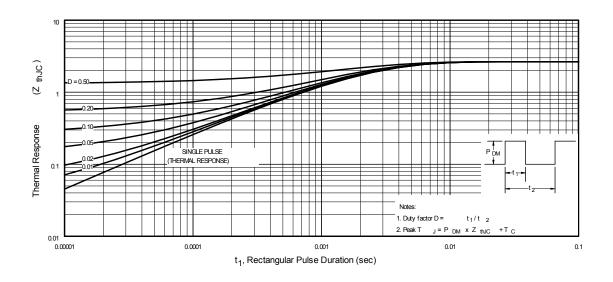


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



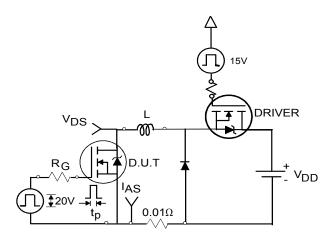


Fig 12a. Unclamped Inductive Test Circuit

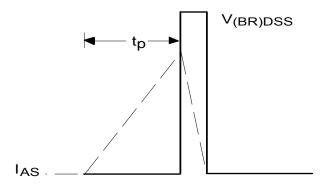


Fig 12b. Unclamped Inductive Waveforms

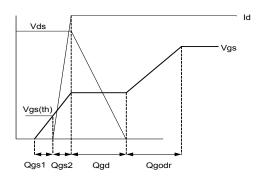


Fig 13a. Gate Charge Waveform

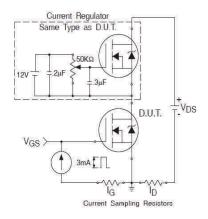


Fig 13b. Gate Charge Test Circuit

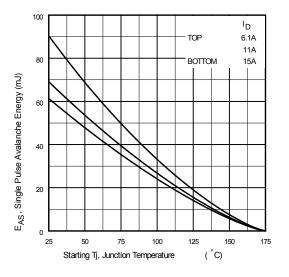


Fig 12c. Maximum Avalanche Energy vs. Drain Current

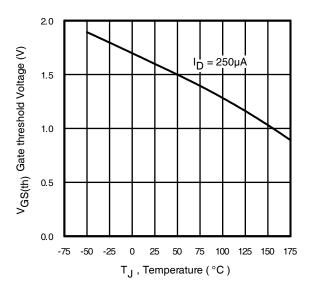


Fig 14. Threshold Voltage Vs. Temperature

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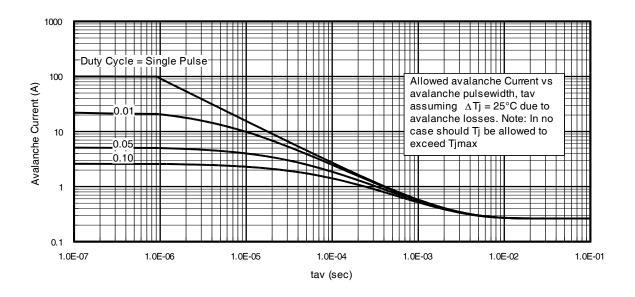
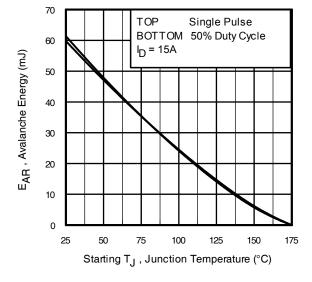


Fig 15. Typical Avalanche Current Vs. Pulse width



**Fig 16.** Maximum Avalanche Energy Vs. Temperature

### Notes on Repetitive Avalanche Curves , Figures 15, 16:

# (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>imax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T<sub>jmax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

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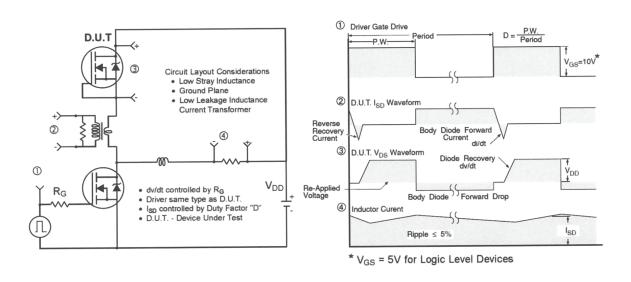


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

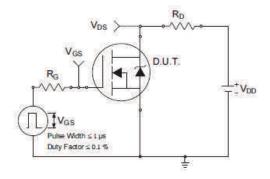


Fig 18a. Switching Time Test Circuit

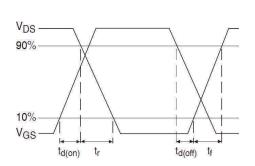
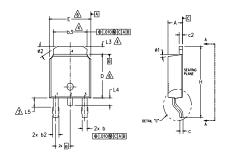


Fig 18b. Switching Time Waveforms

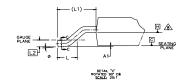
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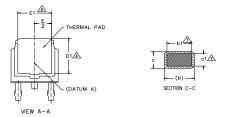


### D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









#### NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 1 LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- Limited Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S					N	
Y M	DIMENSIONS					
B	MILLIM	ETERS	INC	INCHES		
L	MIN.	MAX.	MIN.	MAX.	O T E S	
Α	2.18	2.39	.086	.094		
A1	-	0.13	-	.005		
b	0.64	0.89	.025	.035		
ь1	0.65	0.79	.025	.031	7	
b2	0.76	1.14	.030	.045		
b3	4.95	5.46	.195	.215	4	
С	0.46	0.61	.018	.024		
c1	0.41	0.56	.016	.022	7	
c2	0.46	0.89	.018	.035		
D	5.97	6.22	.235	.245	6	
D1	5.21	-	.205	-	4	
Ε	6.35	6.73	.250	.265	6	
E1	4.32	-	.170	-	4	
е	2.29	2.29 BSC		.090 BSC		
Н	9.40	10.41	.370	.410		
L	1.40	1.78	.055	.070		
L1	2.74	BSC	.108 REF.			
L2	0.51	BSC	.020 BSC			
L3	0.89	1.27	.035	.050	4	
L4	-	1.02	-	.040		
L5	1.14	1.52	.045	.060	3	
ø	0,	10*	0,	10°		
ø1	0,	15*	0,	15*		
ø2	25*	35°	25*	35*		

#### LEAD ASSIGNMENTS

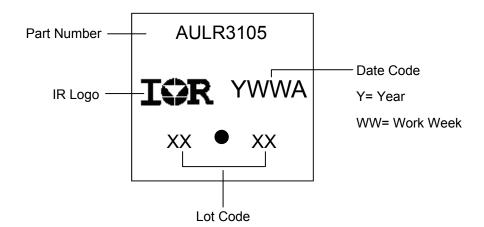
#### **HEXFET**

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

# IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER 4.- COLLECTOR

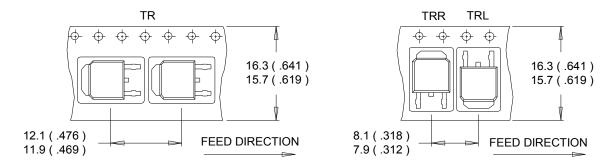
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

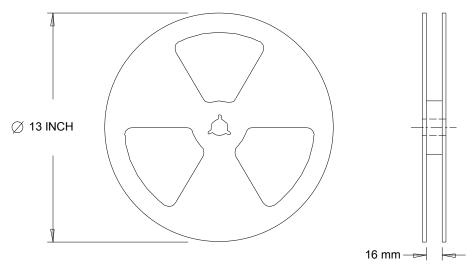


# D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



#### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



# NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



#### **Qualification Information**

	ion inioniation							
		Automotive						
		(per AEC-Q101)						
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.						
Moisture Sensitivity Level		D-Pak MSL1						
	Machine Madel	Class M2 (+/- 200V) <sup>†</sup>						
ESD	Machine Model	AEC-Q101-002						
	Lluman Dady Madal	Class H1A (+/- 500V) <sup>†</sup>						
	Human Body Model	AEC-Q101-001						
	Channed Davies Madel	Class C5 (+/-2000V) <sup>†</sup>						
	Charged Device Model	AEC-Q101-005						
RoHS Compliant		Yes						

<sup>†</sup> Highest passing voltage.

### **Revision History**

Date	Comments		
12/11/2015	Updated datasheet with corporate template		
12/11/2013	Corrected ordering table on page 1.		

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